FBG20N18BC

200 V Radiation Hardened Power eGaN® Datasheet

Features

- Low R_{DS(on)}
- Ultra-low \dot{Q}_{G} For High Efficiency
- Logic Level
- Light Weight
- Compact Hermetic Package
- Source Sense Pin
- Total Ionizing Dose LDR Immune
- Total Ionizing Dose HDR Immune
- Single Event Effect (SEE) Hardened
 - SEE immunity for LET of 83.7 MeV/mg/cm² with V_{DS} up to 100% of rated Breakdown
- Neutron
 - Maintains Pre-Rad specification for up to 4 x 10¹⁵ Neutrons/cm²

Applications

- Satellite and Avionics
- Deep Space Probes
- High Speed Rad-Hard DC-DC Conversion
- Rad-Hard Motor Controllers





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Rad-Hard eGaN[®] 200 V, 18 A, 30 m Ω Surface Mount (FSMD-B)

Description

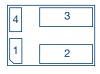
EPC Space FSMD-B series of eGaN[®] power switching HEMTs have been specifically designed for critical applications in Space and other the high reliability environments. These devices have exceptionally high electron mobility and a low temperature coefficient resulting in very low $R_{DS(on)}$ values. The lateral structure of the die provides for very low gate charge (Q_G) and extremely fast switching times. These features enable faster power supply switching frequencies resulting in higher power densities, higher efficiencies and more compact packaging.

Thermal Characteristics

Symbol	Parameter-Conditions	Value	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (Note 3)	56	°C/W
$R_{ extsf{ heta}JC}$	Thermal Resistance Junction to Case	4.02	C/ W

I/O Pin Assignment (Bottom View)

Pin	Symbol	Description
1	G	Gate
2	D	Drain
3	S	Source
4	SS	Source Sense



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Absolute Maximum Rating ($T_c = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter-Conditions	Value	Units
V _{DS}	Drain to Source Voltage (Note 1)	200	V
I _D	Continuous Drain Current ID @ V_{GS} = 5 V	18	۸
I _{DM}	Single-Pulse Drain Current $t_{pulse} \le 80 \ \mu s$	72	A
V _{GS}	Gate to Source Voltage (Note 2)	+6 / -4	V
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to +150	° ^
T _{sol}	Package Mounting Surface Temperature	260	C°
ESD	ESD Class	1Α (ΔΑ)	
Weight	Device Weight	0.135	g

Electrical Characteristics ($T_c = 25^{\circ}C$ unless otherwise noted. Typical (TYP) values are for reference only.)								
Parameter	Symbol	Test Conditions	MIN	ΤΥΡ	MAX	Units		

Parameter	Symbol	Test Con	ditions	MIN	ΤΥΡ	MAX	Units
Minimum Drain to Source Voltage	V _{DSMIN}	$V_{G} = 0 V$		200			V
Drain to Source Leakage	1	V _{DS} = 200 V	$T_{\rm C} = 25^{\circ}{\rm C}$		1.8	250	
Drain to Source Leakage	IDSS	$V_{GS} = 0 V$	T _C = 125°C		50	538	
Gate to Source Forward Leakage	I _{GSSF}	$V_{GS} = 5 V$	$T_{\rm C} = 25^{\circ}{\rm C}$		4	500	μA
Gate to Source Reverse Leakage	I _{GSSR}	$V_{GS} = -4 V$	$T_{\rm C} = 25^{\circ}{\rm C}$		0.14	150	
Gate to Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 5$ mA	$T_{\rm C} = 25^{\circ}{\rm C}$	0.8	1.5	2.5	V
Gate to Source Threshold Voltage Temperature Coefficient	$\Delta V_{GS(th)} / \Delta T$	$V_{DS} = V_{GS}$, $I_D = 5$ mA	-55°C < T _A < 150°C		3.2		mV/°C
Drain to Source Resistance (Note 4)	R _{DS(on)}	$I_{D} = 18 \text{ A}, V_{GS} = 5 \text{ V}$	$T_{\rm C} = 25^{\circ}{\rm C}$		24	30	mΩ
Source to Drain Forward Voltage	V _{SD}	$I_{\rm S} = 0.5 \text{ A}, V_{\rm G} = 0 \text{ V}$	$T_{\rm C} = 25^{\circ}{\rm C}$		3		V

Dynamic Characteristics ($T_c = 25^{\circ}C$ unless otherwise noted. Typical (TYP) values are for reference only.)

Parameter	Symbol	Test Conditions	MIN	ΤΥΡ	MAX	Units
Input Capacitance	C _{ISS}			637	900	
Output Capacitance	C _{OSS}	f = 1 MHz, V_{DS} = 100 V, V_{GS} =0 V		300	359	pF
Reverse transfer Capacitance	C _{RSS}	_		5	13	
Gate Resistance (Note 5)	R _G	$f = 1 \text{ MHz}, V_{DS} = V_{GS} = 0 \text{ V}$		0.4		Ω
Total Gate Charge (Note 6)	Q _G			5	7	
Gate to Drain Charge (Note 6)	Q _{GD}	$I_{D} = 18 \text{ A}, V_{GS} = 5 \text{ V}, V_{DS} = 100 \text{ V}$		1.4	4	
Gate to Source Charge (Note 6)	Q _{GS}	_		1.0	2.5	nC
Output Charge (Note 5)	Q _{OSS}	$V_{GS} = 0 \text{ V}, V_{DS} = 100 \text{ V}$		35		
Source to Drain Recovery Charge (Note 5)	Q _{RR}	I _D = 18 A, V _{DS} = 100 V		<1		

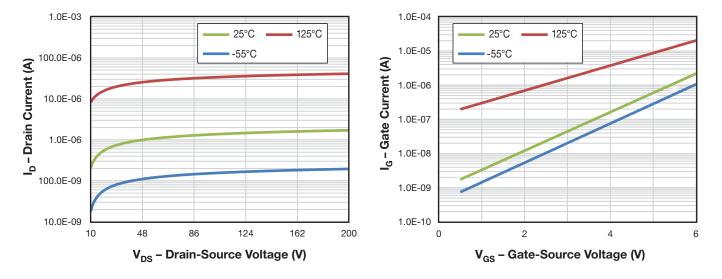


Figure 1. Typical Drain-Source Leakage Current vs. Ambient Temperature

Figure 2. Typical Gate-Source Leakage Current vs. Ambient Temperature

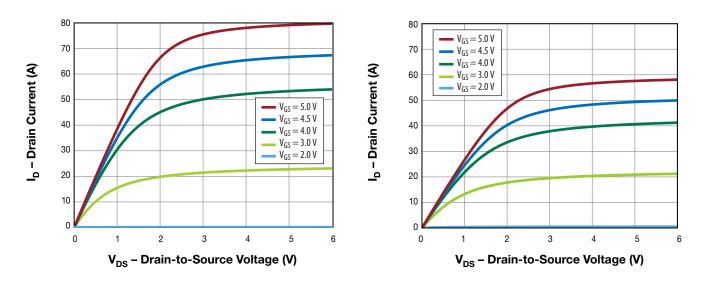


Figure 3. Typical Output Characteristics at 25°C

Figure 4. Typical Output Characteristics at 125°C

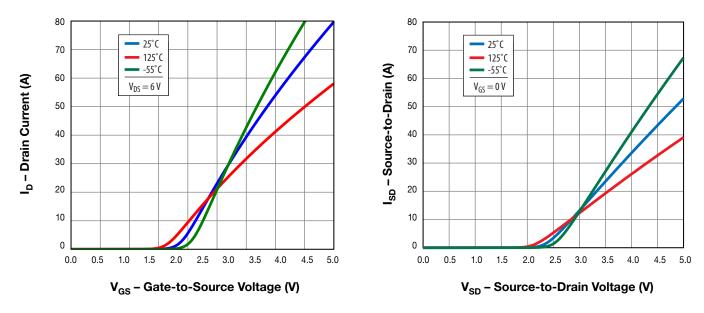
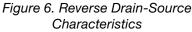
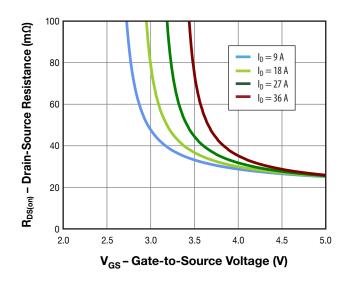


Figure 5. Typical Transfer Characteristics







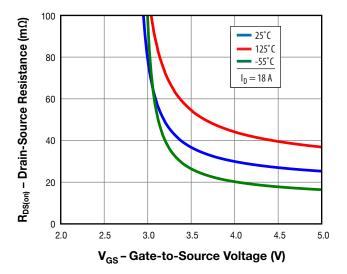


Figure 8. Typical $R_{DS(on)}$ vs. V_{GS} for Various Temperatures

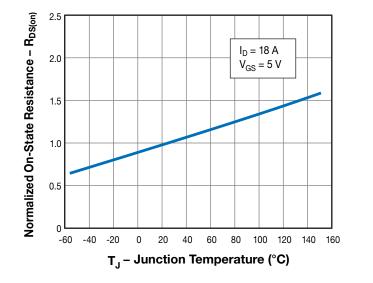


Figure 9. Normalized On-State Resistance vs. Temperature

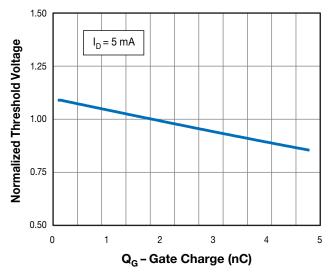


Figure 10. Normalized Threshold Voltage vs. Temperature

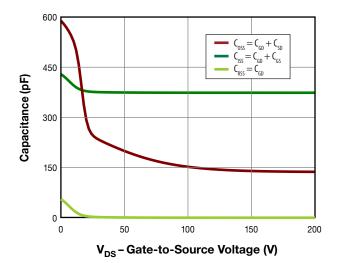


Figure 11. Typical Capacitance

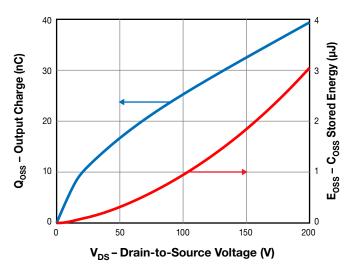


Figure 12. Typical Output Charge and C_{OSS} Stored Energy

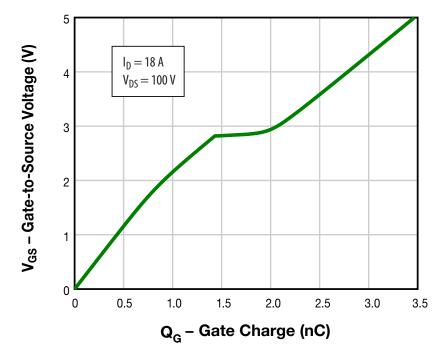


Figure 13. Typical Gate Charge

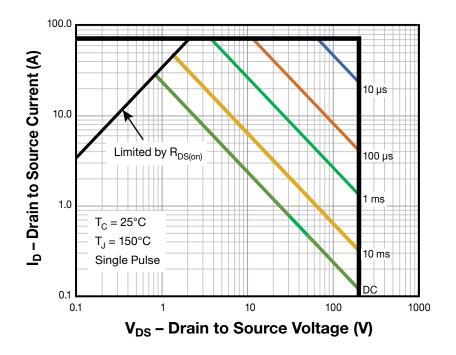


Figure 14. Safe Operating Area

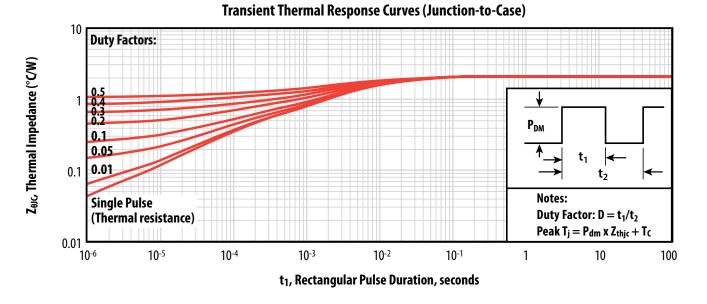


Figure 15. Transient Thermal Impedance, Junction to Case

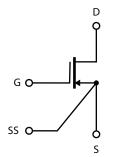
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Package Outline and Ρ **Dimensions** L ĸ D F C N→ ¥ В ¥ G ∱ M Ť J Е А

Symbol	Inches		es Millimeters		Note
Cymbol	MIN	MAX	MIN	MAX	1010
Α	0.027	0.037	0.685	0.939	
В	0.073	0.083	1.854	2.108	
С	0.031	0.041	0.784	1.041	
D	0.143	0.153	3.632	3.886	
Е	0.129	0.139	3.277	3.531	
F	0.027	0.037	0.686	0.940	
G	0.082	0.092	2.083	2.337	
J	0.050	0.060	1.270	1.524	
К	0.078	0.088	1.981	2.235	Ref. only
L	0.215	0.225	5.461	5.715	
М	0.058	0.068	1.473	1.727	
Ν	0.016	0.026	0.406	0.660	
Р	0.145	0.155	3.683	3.937	

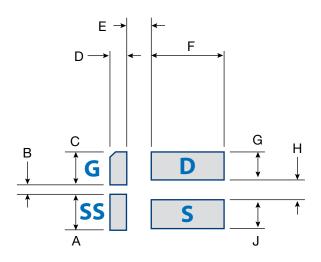
Standard Terminal Pad finish is a solder alloy of 63%Sn 37%Pb

Package Connections



NOTE: SS pin is connected directly to source of internal die.

FSMD-B Footprint for Printed Circuit Board Design



Symbol	Inch	nes	Millim	Note	
e y inizer	MIN	MAX	MIN	MAX	
Α	0.064	0.074	1.626	1.880	
В	0.010	0.020	0.254	0.508	
С	0.064	0.074	1.626	1.880	
D	0.036	0.046	0.914	1.168	
Е	0.034	0.044	0.864	1.118	
F	0.135	0.145	3.429	3.683	
G	0.059	0.069	1.499	1.753	
Н	0.020	0.030	0.508	0.762	
J	0.059	0.069	1.499	1.753	



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Notes

- Note 1. Never exceed the absolute maximum V_{DS} of the device otherwise permanent damage/destruction may result.
- Note 2. Never exceed the absolute maximum V_{GS} of the device otherwise permanent damage/destruction may result. We recommend a V_{GS} of 5 V for optimum operation across life and radiation.
- Note 3. R_{0JA} measured with FSMD-B package mounted to double-sided PCB, 0.063" thickness with 1.0 square inches of copper area on the top (mounting side) and a flood etch (3 square inches) on the bottom side.
- Note 4. Measured using four wire (Kelvin) sensing and pulse measurement techniques. Measurement pulse width is 80 µs and duty cycle is 1%, maximum.
- Note 5. Guaranteed by design/device construction. Not Tested.
- Note 6. The gate charge parameters are measured based on the MIL-STD-750.3471 Condition B. A high speed constant gate current (I_{const}) is provided to the Gate of the DUT during the time that the ground switch (G_S) is OFF (t_{off}). The DUT is switched ON and OFF using ground-sensed switch G_S . The gate current is adjusted to yield the desired charge per unit time (I_{const} · time per division) on the measuring oscilloscope. The G_S pulse drive ON time (t_{on}) is adjusted for the desired observability of the gate-source voltage (V_{GS}) waveform. The maximum duty cycle of the ground switch (t_{off}/t_{on}) should be set to 1% maximum. Please note that all gate-related signals are referenced to the "Source Sense" pin on the package. At all times during the measurement, the maximum gate-source voltage is clamped to 5 V_{DC} .

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